

# 1           **APPARATUS FOR PRECISE DISTANCE MEASUREMENT**

## 2           **BACKGROUND OF THE INVENTION**

### 3           1. Field of the Invention

4           The present invention relates to an apparatus for precise distance  
5           measurement, and specifically to an apparatus that precisely measures a  
6           distance between the apparatus and a target.

### 7           2. Description of Related Art

8           US patent number 5,075,878 discloses a laser measurement device for  
9           measuring the distance between the device and a target. The laser measurement  
10          device uses a zero crossing detection method to calculate the distance. With  
11          reference to Figs. 5A and 5B, the device processes a reflected analog input  
12          signal to calculate the distance by the zero crossing detection method, and then  
13          outputs a square wave signal. With further reference to Fig. 5B, the duration of  
14          the square wave signal is measured by a high frequency signal and then the  
15          device will obtain the phase  $\phi$ .

16          But the laser measurement device disclosed in US patent 5,075,878 had  
17          some shortcomings. When the reflected input signal includes DC bias signal, a  
18          zero point offset is generated in the reflected input signal. The zero point offset  
19          injects an error into the zero crossing detection method. Furthermore, a  
20          reference signal has noise signals so the device executes the square wave signal  
21          with multiple small pulses corresponding to the noises. The small pulses affect  
22          the phase accuracy.

23          The laser measurement device in US patent number 5,075,878 uses  
24          many elements and complex circuits and does not have good performance

1     when measuring distance.

2             The present invention provides an apparatus for precise distance  
3     measurement to mitigate or obviate the aforementioned problems.

#### 4     SUMMARY OF THE INVENTION

5             An object of the present invention is to provide an apparatus for precise  
6     distance measurement that uses simple circuit, fewer elements and phase offset  
7     to measure the distance between the apparatus and a target.

8             To have the above object, the present invention has a multiple  
9     frequency generator, a laser transmitter, optical receiver, a first measuring unit,  
10    a second measuring unit and a central processing unit.

11            The multiple frequency generator generates multiple different  
12    frequency signals to the laser transmitter, the optical receiver, a first and second  
13    measuring unit. The laser transmitter outputs a light signal with a specific  
14    frequency modulated to a target and the light signal will be reflected to the  
15    optical receiver having frequency mixing function. The optical receiver mixes  
16    the reflected light signal with the specific frequency and another frequency  
17    signal from the multiple frequency generator and then outputs a measurement  
18    signal to the first and second measuring units. The first measuring unit  
19    measures a time difference between the light signal and the reflected light  
20    signal. The second measuring unit calculates a phase difference between the  
21    light signal and the reflected light signal. The central processing unit obtains  
22    the time difference and the phase difference and further calculates a distant  
23    between the apparatus and the target.

24            As mentioned above, the present invention uses the optical receiving

1 unit to mix the reflected light signal and one frequency signal to output a  
2 measurement signal so the present invention need not employ extra electronic  
3 mixer to generate the measurement signal. Therefore, the present invention  
4 avoids the worse signal noise rate (SNR) which is caused by the electronic  
5 mixer and the photoelectric conversion device. Therefore the present invention  
6 has high precise distance measurement capability.

7 Another objective of the present invention is to provide a new phase  
8 measuring method to calculate the phase difference precisely and further  
9 increase measurement accuracy.

10 The new phase measuring method, which measures the phase  
11 difference with an IQ orthogonal phase measuring method, is implemented to  
12 the second measuring unit. The new phase measuring method is to delay a  
13 reference signal's phase to  $\frac{\pi}{2}$  phase which is orthogonal with the measurment  
14 signal. Then, the original reference signal and the reference signal with  $\frac{\pi}{2}$   
15 delay phase respecively multiplies by the measurment signal to output two DC  
16 values. The two DC values are divided to obtain a trigonometric function with a  
17 phase difference. Then the phase difference is calculated according to the  
18 trigonometric function. Thus, the second measuring unit can calculate the phase  
19 difference precisely.

20 Other objects, advantages and novel features of the invention will  
21 become more apparent from the following detailed description when taken in  
22 conjunction with the accompanying drawings.

23 BRIEF DESCRIPTION OF THE DRAWINGS

Fig. 1 is a functional block diagram of a first embodiment of an apparatus for precise distance measurement in accordance with the present invention;

Fig. 2 is a timing diagram of a first measurement module in accordance with the present invention;

Fig. 3 is a block diagram of a phase comparator of the apparatus for precise distance measurement in accordance with the present invention;

Fig. 4 is a functional block diagram of a second embodiment of an apparatus for precise distance measurement in accordance with the present invention;

Fig. 5A is a graph of a reflected input signal; and

Fig. 5B is a graph of the results of transforming the reflected input signal in Fig. 5A with a real time zero phase measuring method in accordance with the prior art.

#### DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENT

With reference to Fig. 1, a first embodiment of the present invention includes a multiple frequency generator (50), a laser transmitter (10), an optical receiver (11), a first measuring unit (not numbered), a second measuring unit (not numbered) and a central processing unit (60).

The multiple frequency generator (50) generates a base frequency ( $S_1$ ), an interim frequency ( $S_2$ ) and a transmission frequency ( $S_3$ ), and comprises an oscillator (51), a frequency divider (52) and a frequency synthesizer (53). The oscillator (51) generates the base frequency ( $S_1$ ). The frequency divider (52) is connected to the oscillator (51) and receives the base frequency ( $S_1$ ) from the

oscillator (51) to output the interim signal ( $S_2$ ). The frequency synthesizer (53) is connected to the oscillator (51) and the frequency divider (52) to generate a transmission signal ( $S_3$ ). In a first embodiment, the frequency of the base signal ( $S_1$ ) is 25 MHz. The base signal ( $S_1$ ) is divided to the interim signal ( $S_2$ ) with a fixed frequency by the frequency divider (52). In this embodiment, the fixed frequency of the interim signal ( $S_2$ ) is 6.25KHz. The transmission signal ( $S_3$ ) is a fixed frequency of 25.00625MHz. The transmission signal ( $S_3$ ) is transmitted to the laser transmitter(10), the mixer(43) and the square wave generator(21). The laser transmitter (10) is connected to the frequency synthesizer (53) and transmits a light signal ( $S_{eo}$ ) at the transmission signal ( $S_3$ ) to a target (not numbered). The target reflects the light signal ( $S_{eo}$ ) to the optical receiver (11). Therefore, the reflected light signal ( $S_{eo}$ ) includes the transmission signal ( $S_3$ ) with a phase delay.

The optical receiver (11) is connected to the oscillator (51) to obtain the base signal ( $S_1$ ) and mixes the base signal ( $S_1$ ) and the reflected light signal ( $S_{hr}$ ) to generate a measurement signal ( $S_R$ ). Because the reflected light signal ( $S_{hr}$ ) is an attenuated version of the transmission signal ( $S_3$ ) with a delay based on the path, the measurement signal ( $S_R$ ) has the delay.

The second measuring unit is connected to the optical receiver (11) to receive the measurement signal ( $S_R$ ) therefrom and includes a phase comparator (30), a mixer (43) and a signal corrector (40). The signal corrector (40) is connected between the phase comparator (30) and the optical receiver (11) and has a band-pass filter (41) and a wave form shaper (42). The band-pass filter (41) is connected between the optical receiver (11) and the wave form

1 shaper (42). The band-pass filter (41) filters low frequency noise out of the  
2 measurement signal ( $S_R$ ) to make the measurement signal ( $S_R$ ) a sine wave  
3 signal. Then the wave form shaper (42) modifies the sine wave to a square  
4 wave. The modified measurement signal ( $S_R'$ ) is only processed by the signal  
5 corrector (40) to modify the square shape so the modified measurement signal  
6 ( $S_R'$ ) has the same frequency as the measurement signal ( $S_R$ ) from the optical  
7 receiver (11). In addition to being connected to the signal corrector (40), the  
8 phase comparator (30) is further connected to the central processing unit (60)  
9 and the mixer (43). The mixer (43) provides a reference signal ( $S_m$ ) for the  
10 phase comparator (30) that is the same frequency (6.25KHz) as the modified  
11 measurement signal ( $S_R'$ ). Therefore, the phase comparator (30) calculates a  
12 phase difference between the light signal ( $S_{eo}$ ) and the reflected light signal ( $S_{hr}$ )  
13 by comparing the measurement signal ( $S_R'$ ) and the reference signal ( $S_m$ ).

14 The first measuring unit includes a square wave generator (21) and a  
15 wave-width measuring means (20). The square wave generator (21) is  
16 connected to the optical receiver (11) and the frequency synthesizer (53). The  
17 square wave generator (21) starts outputting a square wave signal upon  
18 receiving the measurement signal and stops outputting the square wave signal  
19 upon receiving the transmission signal ( $S_3$ ). The wave-width measuring means  
20 (20) measures the width of the square wave signal by using the base signal ( $S_1$ )  
21 from the oscillator (51).

22 With reference to Fig. 2, as the laser transmitter (10) receives the  
23 transmission signal ( $S_3$ ) and begins emitting a light beam ( $S_{eo}$ ) to a target,  
24 square wave generator (21) receives the transmission signal ( $S_3$ ) and triggers

1 and holds a voltage level  $V_H$  at the same time. After the optical receiver (11)  
 2 receives the light beam ( $S_{hr}$ ) reflected from the target and outputs the  
 3 measurement signal ( $S_R$ ) to the square wave generator (21), the square wave  
 4 generator (21) restores the voltage level to original status. Thus, the square  
 5 wave generator (21) outputs the square wave signal ( $S_G$ ) to the wave-width  
 6 measuring means (20). The wave-width measuring means (20) calculates the  
 7 wave-width of the square wave signal ( $S_G$ ). The wave-width of the square wave  
 8 signal ( $S_G$ ) is represented as a time difference between the light beam ( $S_{eo}$ ) and  
 9 the reflected light beam ( $S_{hr}$ ). The wave-width measuring means (20) will send  
 10 the time difference to the central processing unit (60).

11 The phase comparator (30) calculates the phase difference by an IQ  
 12 orthogonal phase measuring method. With reference to Fig. 3, the phase  
 13 comparator (30) has a first mixer (31), a phase locked loop (PLL) (32), a first  
 14 low pass filter (LPF) (33), a second mixer (34), a second low pass filter (LPF)  
 15 (35) and a logic arithmetic element (36). The first mixer (31) receives inputs  
 16 from the signal corrector (40) and the mixer (43), and sends an output to the  
 17 first LPF (33). The modified measurement signal ( $S_R'$ ) is in the  
 18 form  $A \sin(\omega t + \phi)$ , and the reference signal ( $S_m$ ) is in the form  $B \sin(\omega t)$ . The  
 19 first mixer (31) mixes the modified measurement signal ( $S_R'$ ) and the reference  
 20 signal ( $S_m$ ), and then outputs a mixed signal to the first LPF (33) to generate a  
 21 first DC value ( $\frac{AB \cos \phi}{2}$ ). The second mixer (34) is connected to the wave  
 22 form shaper (42) and the second LPF (35). The second mixer (34) receives  
 23 inputs from the wave form shaper (42) in the signal corrector (40) and the

1 mixer (43) through the PLL (32).

2 The first mixer (31) mixes the modified measurement signal ( $S_R'$ ) and  
3 the reference signal ( $S_m$ ) and then outputs a mixed signal to the first LPF (33)  
4 to generate a first DC value ( $\frac{AB \cos \phi}{2}$ ).

5 The PLL (32) delays the reference signal ( $S_m$ ) to  $\frac{\pi}{2}$  phase so the delay  
6 reference signal ( $S_m'$ ) is represent to  $B \cos(\omega t)$ . The delay reference signal ( $S_m'$ )  
7 is further input to the second mixer (34) to mix with the modified measurement  
8 signal ( $S_R'$ ). The second mixer (34) outputs a second mixed signal to the  
9 second LPF (33) to generate a second DC value ( $\frac{AB \sin \phi}{2}$ ). Therefore, the  
10 phase comparator (30) outputs a first DC value and second DC value to the  
11 central processing unit (60) through the logic arithmetic element (36). The logic  
12 arithmetic element (36) could be a division device to divide the first and second  
13 DC values. The first and second DC signals are orthogonal so the division  
14 device generates  $\tan \phi$  and further outputs  $\tan \phi$  to the central processing unit  
15 (60). The central processing unit (60) obtains the phase difference ( $\phi$ ) and the  
16 time difference from the first and second measuring units. Therefore, the phase  
17 comparator (30) calculates the phase difference based on the orthogonal  
18 relationship. The present invention does not use the zero crossing detection  
19 method to calculate the phase difference so even if the modified measurement  
20 signal ( $S_R'$ ) has a DC voltage, the phase comparator (30) can calculate the  
21 correct phase difference.

22 With reference to Fig. 4, a second embodiment of the present invention  
23 eliminates the mixer (43) between the multiple frequency generator (50) and



1 the second measuring unit from the first embodiment. Consequently, the phase  
2 comparator (30) is connected directly to the frequency divider (52) to obtain a  
3 interim signal having a frequency that is the same as the mixed frequency of  
4 the reference signal ( $S_m$ ) in the first embodiment.

5 Based on the forgoing description, the present invention measures  
6 distance by calculating the phase difference and time difference between the  
7 light signal and the reflected light signal. The optical receiver (11) can mix the  
8 reflected signal ( $S_{hr}$ ) and the base signal ( $S_1$ ), so the central processing unit can  
9 calculate the phase difference between the light signal ( $S_{eo}$ ) and the reflected  
10 light signal ( $S_{hr}$ ) and further calculate the distant between the present invention  
11 and the target.

12 Even though numerous characteristics and advantages of the present  
13 invention have been set forth in the foregoing description, together with details  
14 of the structure and function of the invention, the disclosure is illustrative only,  
15 and changes may be made in detail, especially in matters of shape, size, and  
16 arrangement of parts within the principles of the invention to the full extent  
17 indicated by the broad general meaning of the terms in which the appended  
18 claims are expressed.